Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
‖‖‖‖‖‖‖‖‖‖ (barcode)	09/666,171	LEWIN ET AL.
	Examiner	Art Unit	
	Jungwon Chang	2154	

SEARCHED

Class	Subclass	Date	Examiner
709	217	9/6/2005	JWC
711	122	9/6/2005	JWC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	**217**	9/6/2005	**JWC**
711	122	9/6/2005	JWC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East text search Google ACM IEEE search report attached	9/6/2005	JWC